

Secondment report

Name: ESR3.1 Shayesteh Masoumian
IRP title: Reliability analysis of SRAM based PUFs in Nano era
From: IID
To: TUD
Period: Nov 2018 - Dec 2018
Oct 2019 - Dec 2019

Activities during the secondment

- **Scope and objectives.**
 - Analysis of the FinFET based SRAM PUF
 - Develop an analytical model for the FinFET based SRAM PUF
 - Develop knowledge about the FinFET physics and existing models for FinFET transistors
 - Improve soft skills by attending in graduate school courses
- **Activities.**
 - Develop an analytical model for the SRAM PUF static noise margin
 - Perform simulations and analysis of the proposed model
 - Attended in soft skills courses at TU Delft
 - Write an academic paper with the achieved results
- **Main results achieved.**
 - Participation in mandatory courses
 - A submitted paper to ETS 2020: "Modeling Static Noise Margin for FinFET based SRAM PUFs"
- **Next steps.**
 - Modification of the proposed model to cover the extreme cases
- **Optional request for support or a technology/tool available at host:**
 - No request

Self-evaluation

Overall score:5

I consider this secondment successful, with regards to the research objectives achieved, skills developed, supervision quality, diversity of the resources. (Agree = 5 ... Disagree = 1)

Optional comments: During my secondment, I had the opportunity to interact with other students and experience the academic environment.

Date of the report approval by the supervisor: 6.1.2020

